Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/732,712	ZHENG, TIEYU	
Examiner	Art Unit	
Derek L. Dupuis	2883	

	SEARCHED					
Class	Subclass	Date	Examiner			
			·········			
		,				
	· · · · · · · · · · · · · · · · · · ·					
	:					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u></u>		-	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated BRS search in EAST (USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) - see attached	8/2/2006	DLD